

## 650V N-Channel MOSFET

#### **General Features**

- Advanced Planar Process
- >  $R_{DS(ON),typ.}$ =280 m $\Omega$ @V<sub>GS</sub>=10V
- Low Gate Charge Minimize Switching Loss
- Rugged Poly silicon Gate Structure

# **Applications**

- BLDC Motor Driver
- Electric Welder
- ➢ High Efficiency SMPS

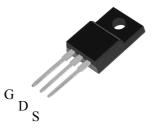
## **Ordering Information**

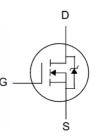
Part Nur	nber	Package	Brand
PTA26	N65	TO-220F	ï

# Absolute Maximum Ratings

## Dead Free Package and Finish

BV <sub>DSS</sub>	R <sub>DS(ON),typ.</sub> I <sub>D</sub>	
650V	280mΩ	26A





TO-220F Package

 $T_C {=} 25\,^\circ\!\mathrm{C}$  unless otherwise specified

Symbol	Parameter	PTA26N65	Unit
V <sub>DSS</sub>	Drain-to-Source Voltage	650	V
V <sub>GSS</sub>	Gate-to-Source Voltage	±30	
1	Continuous Drain Current	26	
I <sub>D</sub>	Continuous Drain Current @ Tc=100°C	17	A
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2,4]</sup>	104	
E <sub>AS</sub>	Single Pulse Avalanche Energy	1000	mJ
dv/dt	Peak Diode Recovery dv/dt <sup>[3]</sup>	5.0	V/ns
D	Power Dissipation	82	W
P <sub>D</sub>	Derating Factor above 25°C	0.66	W/℃
T <sub>L</sub> T <sub>PAK</sub>	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	Ĉ
T <sub>J</sub> & T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

## **Thermal Characteristics**

Symbol	Parameter PTA26N65		Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	1.52	
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	100	°C <b>M</b>

# **Electrical Characteristics**

#### **OFF Characteristics** T<sub>J</sub> =25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	650			V	$V_{GS}$ =0V, I <sub>D</sub> =250uA
I <sub>DSS</sub>	Drain-to-Source Leakage Current			1		V <sub>DS</sub> =650V, V <sub>GS</sub> =0V
		-		125	uA	V <sub>DS</sub> =520V, V <sub>GS</sub> =0V, T <sub>J</sub> =125℃
I <sub>GSS</sub>	Gate-to-Source Leakage Current			+100	nA	$V_{GS}$ =+30V, $V_{DS}$ =0V
				-100	ПA	V <sub>GS</sub> =-30V, V <sub>DS</sub> =0V

### **ON Characteristics**

N Characteristics				$T_J$ =25 $^\circ\!\!\!\!\!^\circ\!\!\!\!^\circ$ unless otherwise specified		
Symbol	Parameter	Min.	Тур.	Max.	Unit	<b>Test Conditions</b>
R <sub>DS(ON)</sub>	Static Drain-to-Source On-Resistance		280	380	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =13A
$V_{GS(TH)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS}=V_{GS}$ , $I_D=250$ uA
gfs	Forward Transconductance		32		S	VDS =25V, ID=13A

#### **Dynamic Characteristics**

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C <sub>iss</sub>	Input Capacitance		4.20			V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MH <sub>Z</sub>
C <sub>rss</sub>	Reverse Transfer Capacitance		0.20		nF	
C <sub>oss</sub>	Output Capacitance		1.40			
Qg	Total Gate Charge		78			
Q <sub>gs</sub>	Gate-to-Source Charge		21		nC	V <sub>DD</sub> =325V, I <sub>D</sub> =26A, V <sub>GS</sub> =0 to 10V
Q <sub>gd</sub>	Gate-to-Drain (Miller) Charge		20			

### **Resistive Switching Characteristics**

Essentially independent of operating temperature

<b>J</b>			1		- /	serraeint er operaning temperature
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		30		- nS	V <sub>DD</sub> =325V, I <sub>D</sub> =13A, V <sub>GS</sub> = 10V RG=10Ω
trise	Rise Time		60			
td(OFF)	Turn-Off Delay Time		55			
tfall	Fall Time		65			

## **Source-Drain Body Diode Characteristics**

 $T_J {=} 25\,^\circ\!\! {\rm C}$  unless otherwise specified

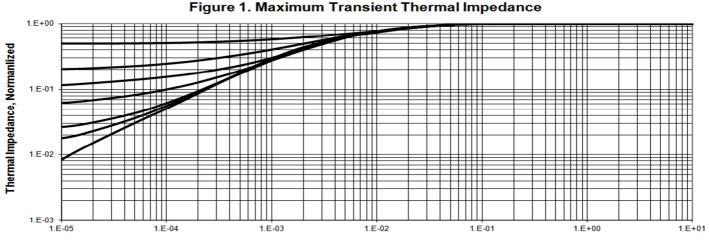
Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions	
I <sub>SD</sub>	Continuous Source Current <sup>[2]</sup>			26	A	Integral PN-diode in MOSFET	
I <sub>SM</sub>	Pulsed Source Current <sup>[2]</sup>			104			
V <sub>SD</sub>	Diode Forward Voltage			1.5	V	I <sub>S</sub> =26A, V <sub>GS</sub> =0V	
trr	Reverse recovery time		600		ns	V <sub>GS</sub> =0V ,I <sub>F</sub> =26A,	
Qrr	Reverse recovery charge		5.5		uC	di⊧/dt=100A/µs	

#### Note:

[1]  $T_{\rm J}\text{=+}25\,^\circ\!\!\mathbb{C}$  to +150 $^\circ\!\!\mathbb{C}$  .

- [2] Silicon limited current only.
- [2] Sincon infinited current only.
  [3] Package limited current.
  [4] Repetitive rating; pulse width limited by maximum junction temperature.
  [5] Pulse width≤380µs; duty cycle≤2%.

# **Typical Characteristics**



Rectangular Pulse Duration, Seconds

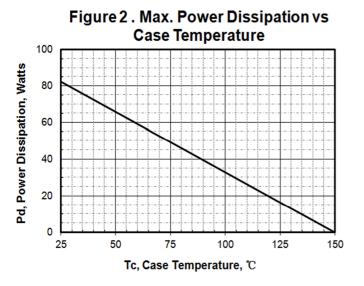


Figure 4. Output Characteristics

32

28

24 20

16

12

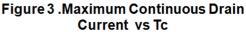
8.0

4.0

0

0

ld, Drain Current, Amps



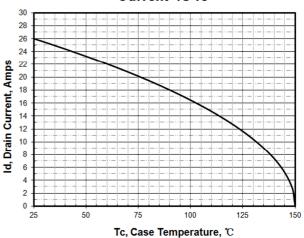
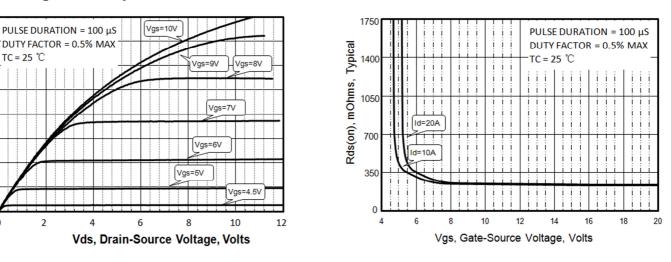
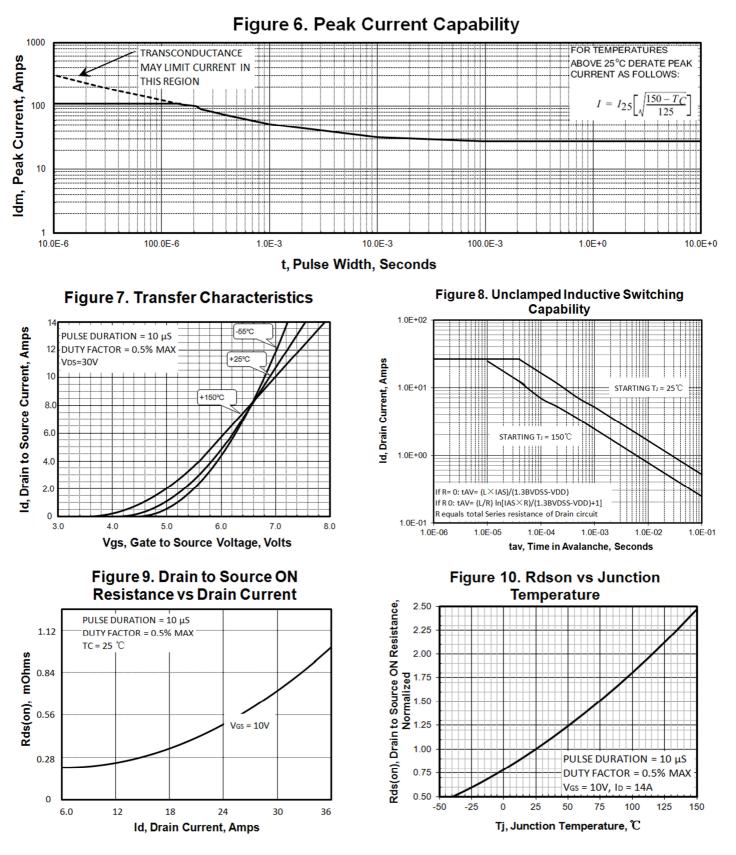


Figure 5. Rdson vs Gate Voltage





# **Typical Characteristics**(Cont.)



## Typical Characteristics(Cont.)

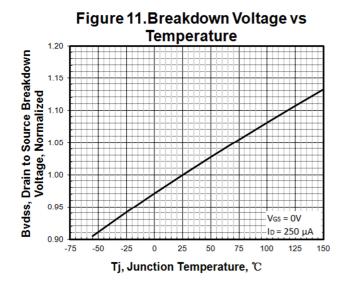
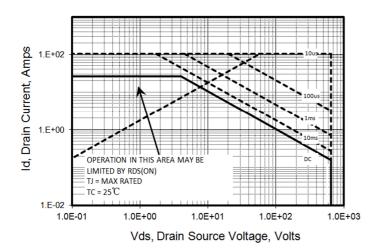
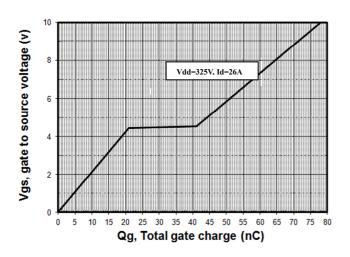


Figure 13 . Maximum Safe Operating Area







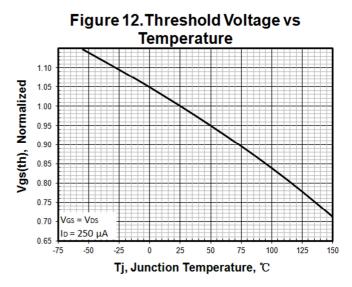


Figure 14. Capacitance vs Vds

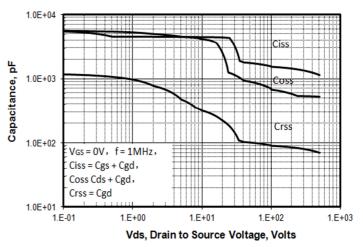
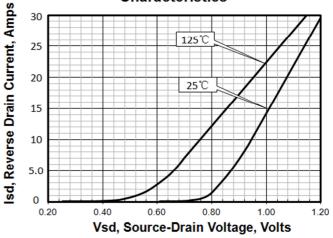
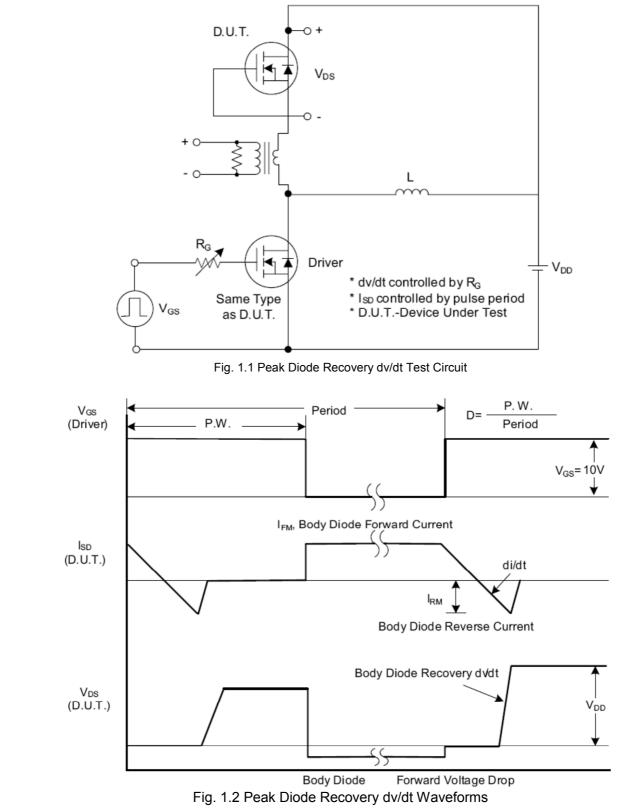


Figure 16.Body Diode Transfer Characteristics



## **Test Circuits and Waveforms**



# **PTA26N65**

# Test Circuits and Waveforms (Cont.)

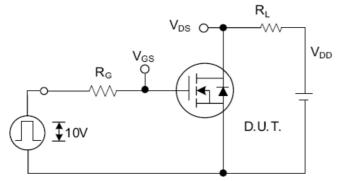


Fig. 2.1 Switching Test Circuit

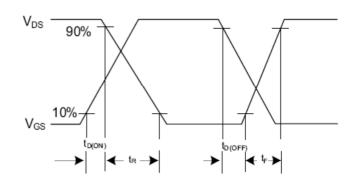


Fig. 2.2 Switching Waveforms

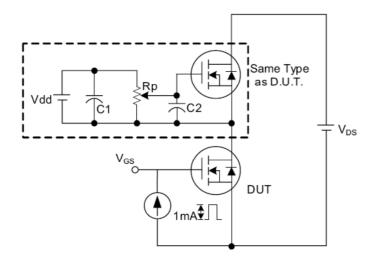


Fig. 3 . 1 Gate Charge Test Circuit

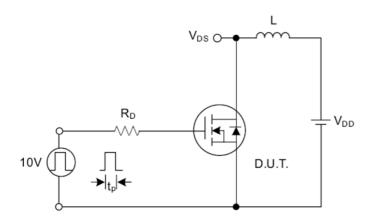
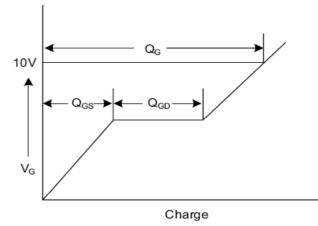
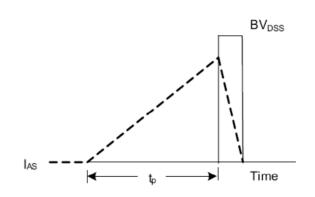
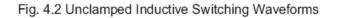


Fig. 4.1 Unclamped Inductive Switching Test Circuit









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